Rev. 3 — 30 March 20

Product data sheet

1. Product profile

1.1 General description

Planar passivated sensitive gate four quadrant triac in a SOT428 (DPAK) surface-mountable plastic package intended for use in general purpose bidirectional switching and phase control applications. This sensitive gate "series E" triac is intended to be interfaced directly to microcontrollers, logic integrated circuits and other low power gate trigger circuits.

1.2 Features and benefits

- Direct triggering from low power drivers and logic ICs
- High blocking voltage capability
- Low holding current for low current loads and lowest EMI at commutation
- Planar passivated for voltage ruggedness and reliability
- Sensitive gate
- Surface-mountable package
- Triggering in all four quadrants

1.3 Applications

General purpose motor control

General purpose switching

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|--|---|-----|-----|-----|------|
| V_{DRM} | repetitive peak off-state voltage | | - | - | 600 | V |
| I _{TSM} | non-repetitive peak on-state current | full sine wave; $T_{j(init)} = 25$ °C; $t_p = 20$ ms; see Figure 4; see Figure 5 | - | - | 65 | Α |
| I _{T(RMS)} | RMS on-state current | full sine wave; T _{mb} ≤ 102 °C; see <u>Figure 1</u> ; see <u>Figure 2</u> ; see <u>Figure 3</u> | - | - | 8 | Α |



Table 1. Quick reference data ...continued

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------|-------------------------|--|-----|-----|-----|------|
| Static char | acteristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{ C}}$ | - | 2.5 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G - ;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{Figure 7}}$ | - | 4 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; T2- G-;}$ $T_j = 25 ^{\circ}\text{C; see } \frac{\text{Figure 7}}{\text{Figure 7}}$ | - | 5 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; T2- G+;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{\text{Figure 7}}$ | - | 11 | 25 | mA |
| I _H | holding current | $V_D = 12 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 9</u> | - | 2.5 | 20 | mA |

2. Pinning information

Table 2. Pinning information

| | | , | | |
|-----|--------|-----------------------------------|--------------------|----------------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | T1 | main terminal 1 | | N 1 |
| 2 | T2 | main terminal 2 | mb | T2—T1 |
| 3 | G | gate | | ` G sym051 |
| mb | T2 | mounting base; main terminal 2 | 1 3 | |
| | | | SOT428 (DPAK) | |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|---------|---|---------|
| | Name | Description | Version |
| BT137S-600E | DPAK | plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped) | SOT428 |

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|--------------------------------------|--|-----|-----|--------|
| V_{DRM} | repetitive peak off-state voltage | | - | 600 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; T _{mb} ≤ 102 °C; see <u>Figure 1</u> ; see <u>Figure 2</u> ; see <u>Figure 3</u> | - | 8 | Α |
| I _{TSM} | non-repetitive peak on-state current | full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 20 \text{ ms}$; see <u>Figure 4</u> ; see <u>Figure 5</u> | - | 65 | Α |
| | | full sine wave; $T_{j(init)} = 25 \text{ °C}$; $t_p = 16.7 \text{ ms}$ | - | 71 | Α |
| I ² t | I ² t for fusing | t _p = 10 ms; sine-wave pulse | - | 21 | A^2s |
| dl _T /dt | rate of rise of on-state current | I_T = 12 A; I_G = 0.2 A; dI_G/dt = 0.2 A/ μ s; T2+ G+ | - | 50 | A/µs |
| | | I_T = 12 A; I_G = 0.2 A; dI_G/dt = 0.2 A/ μ s; T2+ G- | - | 50 | A/µs |
| | | I_T = 12 A; I_G = 0.2 A; dI_G/dt = 0.2 A/ μ s; T2- G- | - | 50 | A/µs |
| | | I_T = 12 A; I_G = 0.2 A; dI_G/dt = 0.2 A/ μ s; T2- G+ | - | 10 | A/µs |
| I _{GM} | peak gate current | | - | 2 | Α |
| V_{GM} | peak gate voltage | | - | 5 | V |
| P _{GM} | peak gate power | | - | 5 | W |
| $P_{G(AV)}$ | average gate power | over any 20 ms period | - | 0.5 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| Tj | junction temperature | | - | 125 | °C |

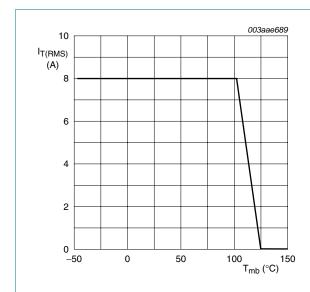
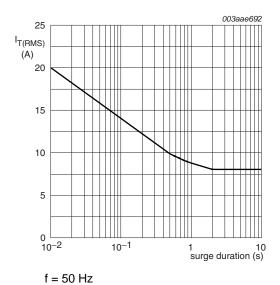


Fig 1. RMS on-state current as a function of mounting base temperature; maximum values



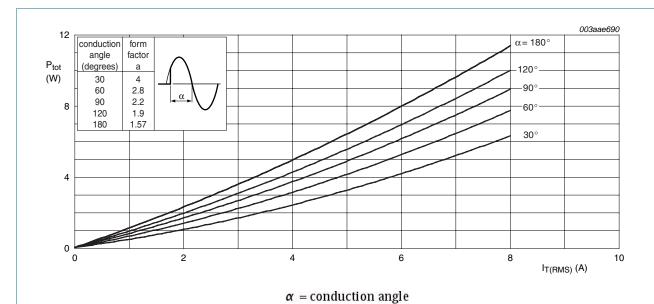
 $T_{mb} \le 102 \,^{\circ}\text{C}$

Fig 2. RMS on-state current as a function of surge duration; maximum values

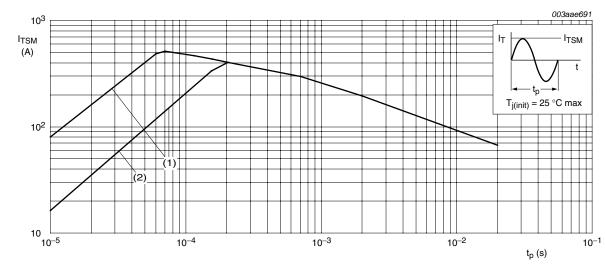
BT137S-600E

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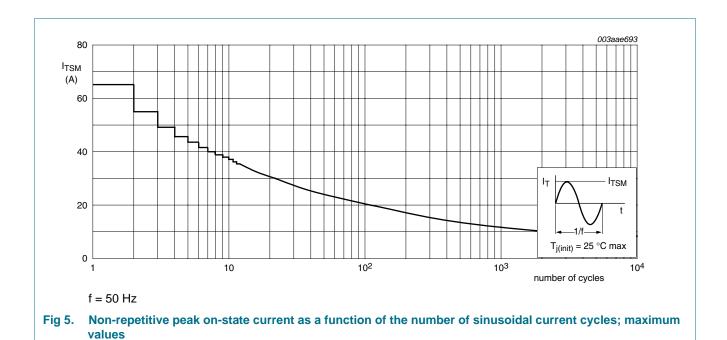
3. Total power dissipation as a function of RMS on-state current; maximum values



t_p ≤ 20 ms

- (1) dI_T/dt limit
- (2) T2- G+ quadrant limit

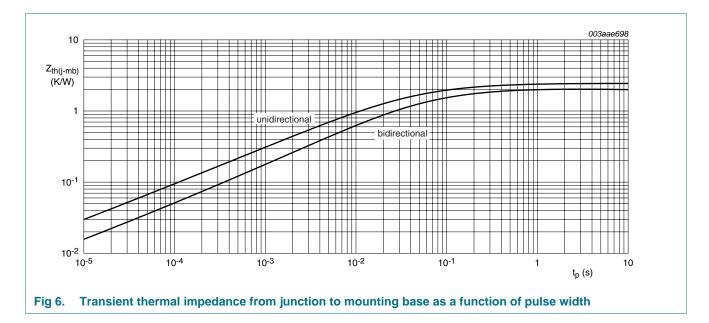
Fig 4. Non-repetitive peak on-state current as a function of pulse width; maximum values



5. Thermal characteristics

Table 5. Thermal characteristics

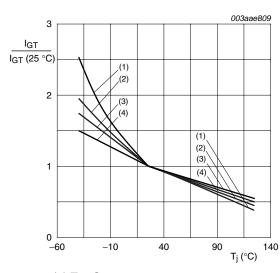
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|----------------|---|--------------------------------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance | half cycle; see Figure 6 | - | - | 2.4 | K/W |
| | from junction to mounting base | full cycle; see Figure 6 | - | - | 2 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | PCB (FR4) mounted; minimum pad sizes | - | 75 | - | K/W |



6. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------------|-----------------------------------|--|------|-----|------|------|
| Static cha | racteristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$ | - | 2.5 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$ | - | 4 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G-;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$ | - | 5 | 10 | mA |
| | | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T2\text{- G+;} $ $T_j = 25 \text{ °C; see } \frac{\text{Figure 7}}{}$ | - | 11 | 25 | mA |
| I _L latching | latching current | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2 + G+;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 8}}{}$ | - | 3 | 25 | mA |
| | | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; } T2 + G-;$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 8}}{}$ | - | 14 | 35 | mA |
| | | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; T2- G-;}$ $T_j = 25 \text{ °C; see } \frac{\text{Figure 8}}{}$ | - | 3 | 25 | mA |
| | | $V_D = 12 \text{ V; } I_G = 0.1 \text{ A; T2- G+;}$ $T_j = 25 \text{ °C; see Figure 8}$ | - | 4 | 35 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; see <u>Figure 9</u> | - | 2.5 | 20 | mΑ |
| V _T | on-state voltage | I _T = 10 A; T _j = 25 °C; see <u>Figure 10</u> | - | 1.3 | 1.65 | V |
| V_{GT} | gate trigger voltage | $V_D = 12 \text{ V; } I_T = 0.1 \text{ A; } T_j = 25 \text{ °C;}$ see Figure 10 | - | 0.7 | 1.5 | V |
| | | $V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 125 \text{ °C};$ see Figure 10 | 0.25 | 0.4 | - | V |
| I _D | off-state current | V _D = 600 V; T _j = 125 °C | - | 0.1 | 0.5 | mΑ |
| Dynamic | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 125 °C; exponential waveform; gate open circuit | - | 50 | - | V/µs |
| t _{gt} | gate-controlled turn-on time | $I_{TM} = 12 \text{ A}; V_D = 600 \text{ V}; I_G = 0.1 \text{ mA};$ $dI_G/dt = 5 \text{ A}/\mu\text{s}$ | - | 2 | - | μs |



- (1) T2- G+
- (2) T2- G-
- (3) T2+ G-
- (4) T2+ G+

Fig 7. Normalized gate trigger current as a function of junction temperature

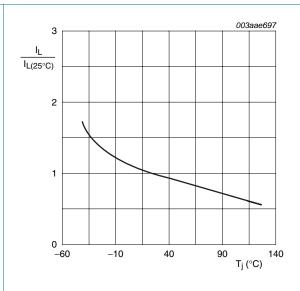


Fig 8. Normalized latching current as a function of junction temperature

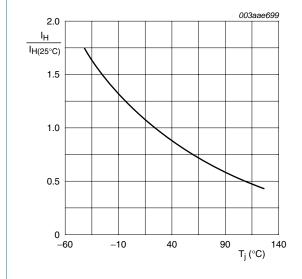
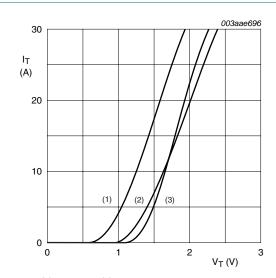


Fig 9. Normalized holding current as a function of junction temperature



 $V_0 = 1.264 \text{ V}$

 $R_s = 0.038 \Omega$

(1) T_i = 125 °C; typical values

(2) T_j = 125 °C; maximum values

(3) T_i = 25 °C; maximum values

Fig 10. On-state current as a function of on-state voltage

7. Package outline

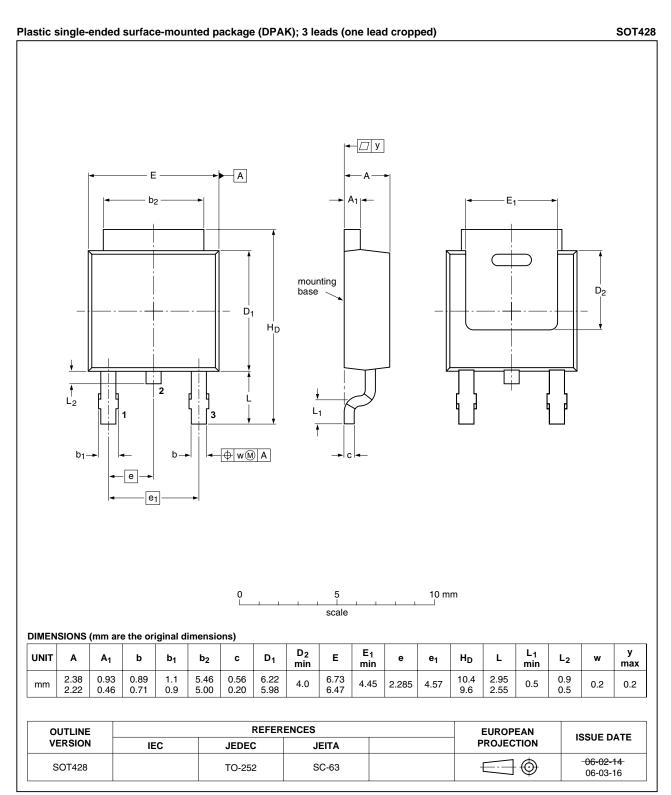
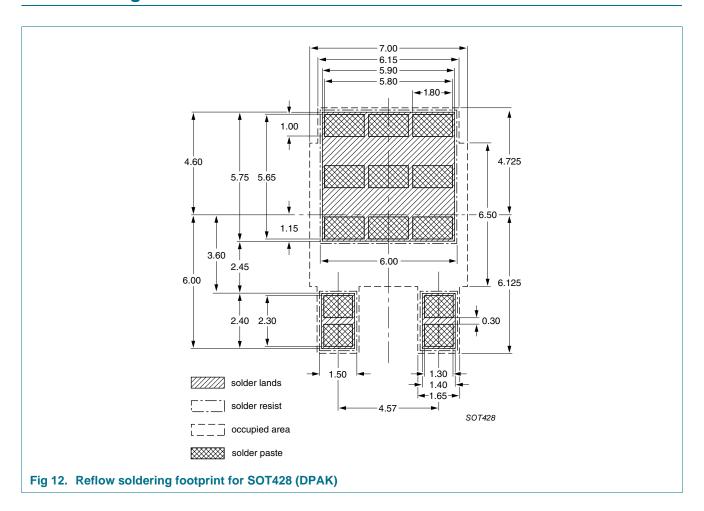


Fig 11. Package outline SOT428 (DPAK)

8. Soldering



9. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-------------------|---|--|-----------------------|-------------------|
| BT137S-600E v.3 | 20110330 | Product data sheet | - | BT137S_SERIES_E_2 |
| Modifications: | | format of this data sheet has been redesigned to comply with the new identity guideli XP Semiconductors. | | |
| | Legal texts have be | een adapted to the new c | ompany name where app | propriate. |
| | Type number BT13 | 37S-600E separated from | data sheet BT137S_SEF | RIES_E_2. |
| BT137S_SERIES_E_2 | 20010601 | Product specification | - | BT137S_SERIES_E_1 |

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|--------------------------------|--------------------|---|
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